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Vishay Siliconix

P-Channel 12 V (D-S) MOSFET

PRODU	CT SUMMARY		
V _{DS} (V)	R _{DS(on)} (Ω) (Max.)	I _D (A)	Q _g (Typ.)
	0.0082 at V _{GS} = - 4.5 V	- 25ª	
- 12	0.0094 at V _{GS} = - 3.7 V	- 25ª	43 nC
- 12	0.0117 at V _{GS} = - 2.5 V	- 25 ^a	43 110
	0.0206 at V _{GS} = - 1.8 V	- 15	

PowerPAK ChipFET Single **Bottom View**

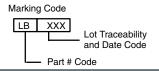
Ordering Information: Si5411EDU-T1-GE3 (Lead (Pb)-free and Halogen-free)

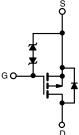
FEATURES

- TrenchFET® Power MOSFET
- Thermally Enhanced PowerPAK® ChipFET Package
 - Small Footprint Area
 - Low On-Resistance
- 100 % R_q and UIS Tested
- Typical ESD Protection: 5000 V (HBM)
- Material categorization: For definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- · Portable Devices such as Smart Phones, Tablet PCs and Mobile Computing
 - Battery Switch
 - Load Switch
 - Power Management





COMPLIANT

HALOGEN

FREE

) D
P-Channel MOSFE

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ C, unless		٦)	1	
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 12	V	
Gate-Source Voltage		V _{GS}	± 8	V	
	T _C = 25 °C		- 25 ^a		
Oti	T _C = 70 °C		- 25ª	1	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 16.5 ^{b, c}		
	T _A = 70 °C		- 13 ^{b, c}	Δ.	
Pulsed Drain Current (t = 100 μs)	•	I _{DM}	- 140	A	
Continuous Courses Drain Diade Current	T _C = 25 °C		- 25 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.6 ^{b, c}		
Single Avalanche Current		I _{AS}	- 15	1	
Single Avalanche Energy	L = 0.1 mH	E _{AS}	11	mJ	
	T _C = 25 °C		31		
Maniana Danas Dissination	T _C = 70 °C		20] w	
Maximum Power Dissipation	T _A = 25 °C	P _D	3.1 ^{b, c}	7 vv	
	T _A = 70 °C		2 ^{b, c}	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 50 to 150	00	
Soldering Recommendations (Peak Temperature	-	260	°C		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	34	40	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3	4	C/ VV

Notes

- a. Package limited.
- Surface mounted on 1" x 1" FR4 board.
- See solder profile (www.vishay.com/doc?73257). The PowerPAK ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 90 °C/W.

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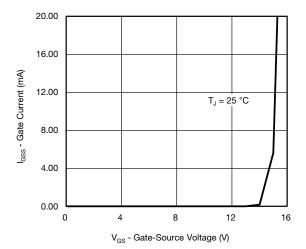
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 12			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		- 5			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		1.8		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.4		- 0.9	V	
Octo Course Leelines	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 2	μΑ	
Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$			± 0.2		
Zon Oak Waller a Built Oomal	I _{DSS}	V _{DS} = - 12 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current		V _{DS} = - 12 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 10			Α	
		V _{GS} = - 4.5 V, I _D = - 6 A		0.0066	0.0082		
Dualin Course On Chata Daniatauras	Б	$V_{GS} = -3.7 \text{ V}, I_D = -5 \text{ A}$		0.0073	0.0094		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 2.5 V, I _D = - 5 A		0.0095	0.0117	Ω	
		V _{GS} = - 1.8 V, I _D = - 2 A		0.0155	0.0206	1	
Forward Transconductance ^a	9 _{fs}	V _{GS} = - 6 V, I _D = - 6 A		45		S	
Dynamic ^b				•			
Input Capacitance	C _{iss}			4100			
Output Capacitance	C _{oss}	$V_{DS} = -6 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		860		pF	
Reverse Transfer Capacitance	C _{rss}			870			
Total Cata Obassa	Qg	V _{DS} = -6 V, V _{GS} = -8 V, I _D = -15 A		70	105	0	
Total Gate Charge				43	65		
Gate-Source Charge	Q_{gs}	$V_{DS} = -6 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -15 \text{ A}$		5.5		nC	
Gate-Drain Charge	Q_{gd}			10.5			
Gate Resistance	R_g	f = 1 MHz	0.7	3.6	7.2	Ω	
Turn-On Delay Time	t _{d(on)}			30	60		
Rise Time	t _r	$V_{DD} = -6 \text{ V}, R_L = 0.6 \Omega$		30	60		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		70	140		
Fall Time	t _f			35	70		
Turn-On Delay Time	t _{d(on)}			12	25	ns	
Rise Time	t _r	$V_{DD} = -6 \text{ V}, R_{L} = 0.6 \Omega$		5	10		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -10$ A, $V_{GEN} = -8$ V, $R_g = 1$ Ω		80	160		
Fall Time	t _f			25	50		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			- 25	۸	
Pulse Diode Forward Current (100 µs)	I _{SM}				- 140	А	
Body Diode Voltage	V_{SD}	I _S = - 10 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			45	90	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	10.0 dl/dt 100.0/ T 05.00		35	70	nC	
Reverse Recovery Fall Time	ta	$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 °C$		17		ns	
Reverse Recovery Rise Time	t _b			28			

Notes

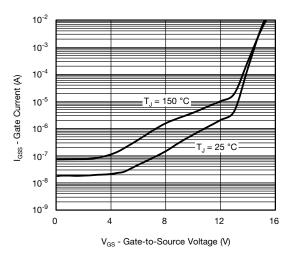
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

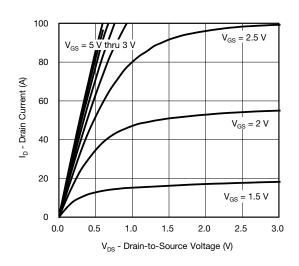




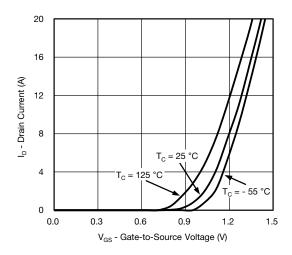
Gate Current vs. Gate-Source Voltage



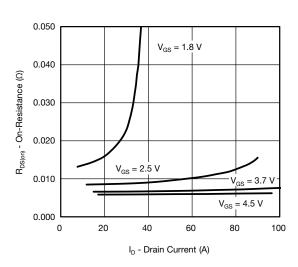
Gate Current vs. Gate-Source Voltage



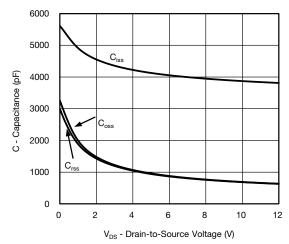
Output Characteristics



Transfer Characteristics

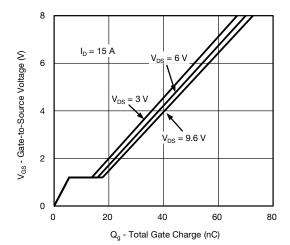


On-Resistance vs. Drain Current and Gate Voltage

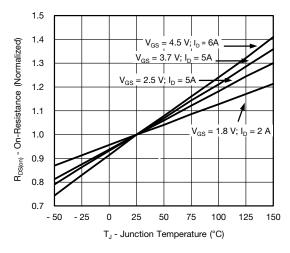


Capacitance

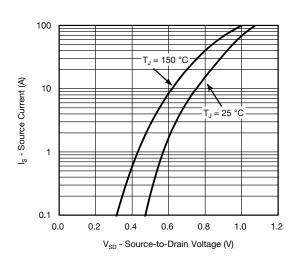




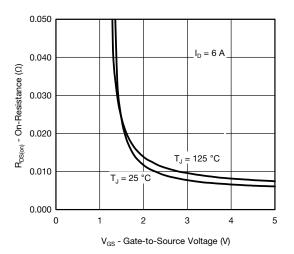
Gate Charge



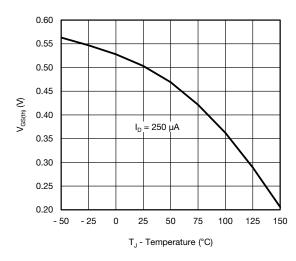
On-Resistance vs. Junction Temperature



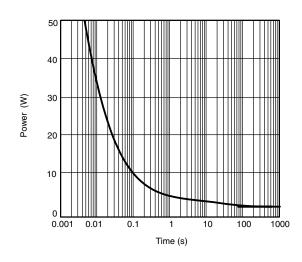
Soure-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage

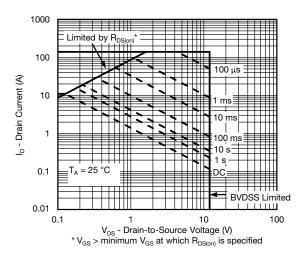


Threshold Voltage

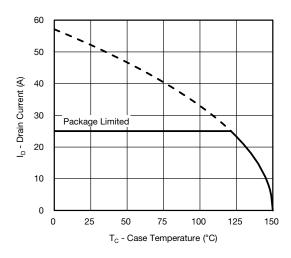


Single Pulse Power, Junction-to-Ambient

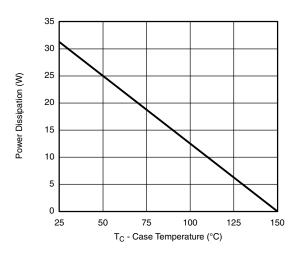




Safe Operating Area, Junction-to-Ambient



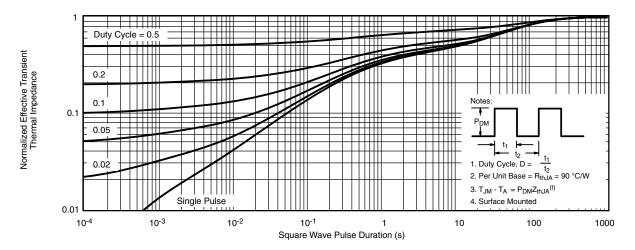




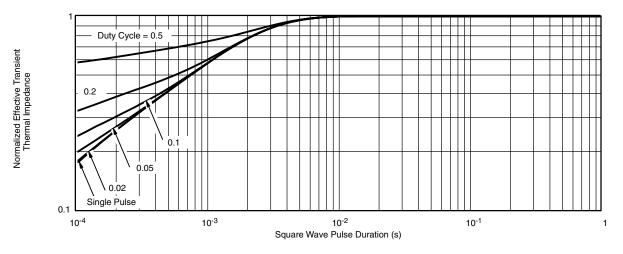
Power Derating

^{*} The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

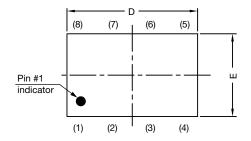


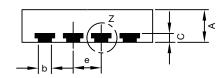
Normalized Thermal Transient Impedance, Junction-to-Case

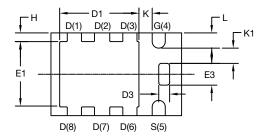
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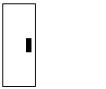
PowerPAK® ChipFET® Case Outline







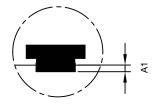
Backside view of single pad



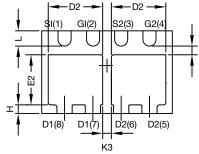
Side view of single



Side view of dual



Detail Z



Backside view of dual pad

DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.70	0.75	0.85	0.028	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D	2.92	3.00	3.08	0.115	0.118	0.121	
D1	1.75	1.87	2.00	0.069	0.074	0.079	
D2	1.07	1.20	1.32	0.042	0.047	0.052	
D3	0.20	0.25	0.30	0.008	0.010	0.012	
E	1.82	1.90	1.98	0.072	0.075	0.078	
E1	1.38	1.50	1.63	0.054	0.059	0.064	
E2	0.92	1.05	1.17	0.036	0.041	0.046	
E3	0.45	0.50	0.55	0.018	0.020	0.022	
е	0.65 BSC			0.026 BSC			
Н	0.15	0.20	0.25	0.006	0.008	0.010	
K	0.25	-	-	0.010	-	-	
K1	0.30	-	-	0.012	-	-	
K2	0.20	-	-	0.008	-	-	
K3	0.20	-	-	0.008	-	-	
L	0.30	0.35	0.40	0.012	0.014	0.016	

C14-0630-Rev. E, 21-Jul-14

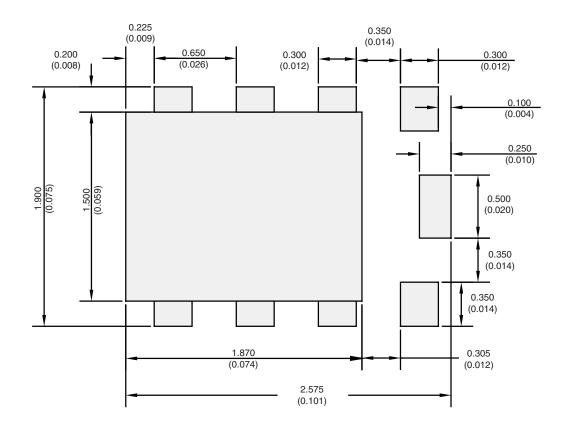
DWG: 5940

Note

Millimeters will govern



RECOMMENDED MINIMUM PADS FOR PowerPAK® ChipFET® Single



Recommended Minimum Pads Dimensions in mm/(Inches)

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APPLICATION NOTE



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